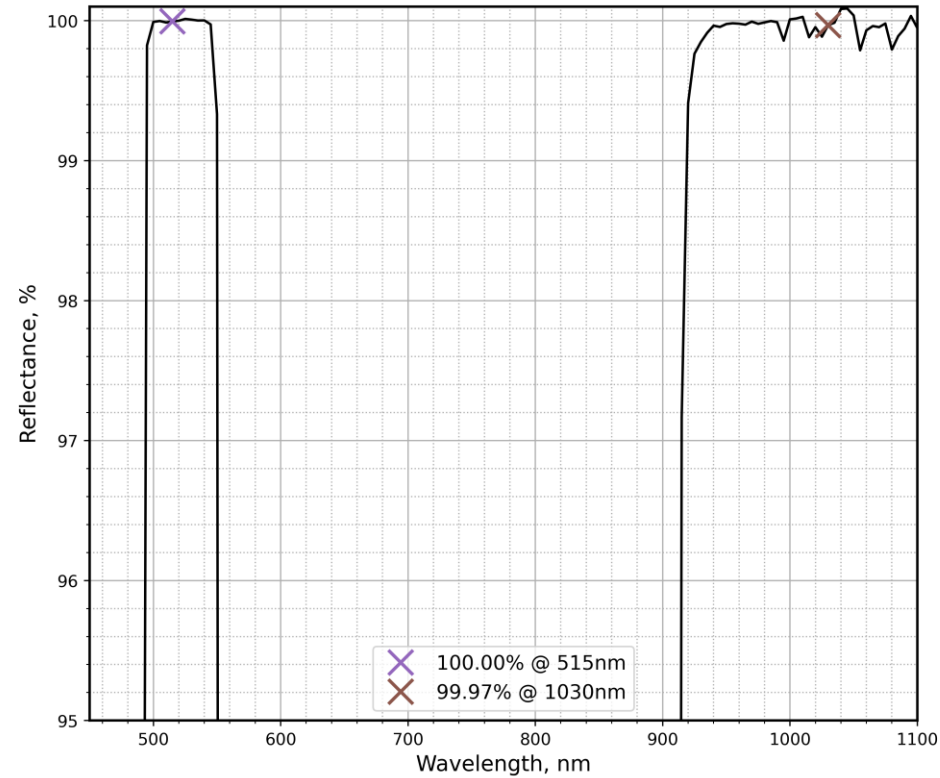


S1: (arrow marks) HRsp>99.9% @ 1030 nm & HRsp>99.9% @ 515 nm, AOI=45° |GDD Rs|<10 fs², |GDD Rp|<20 fs² @ 1030 nm & 515 nm, AOI=45°
S2: SCC



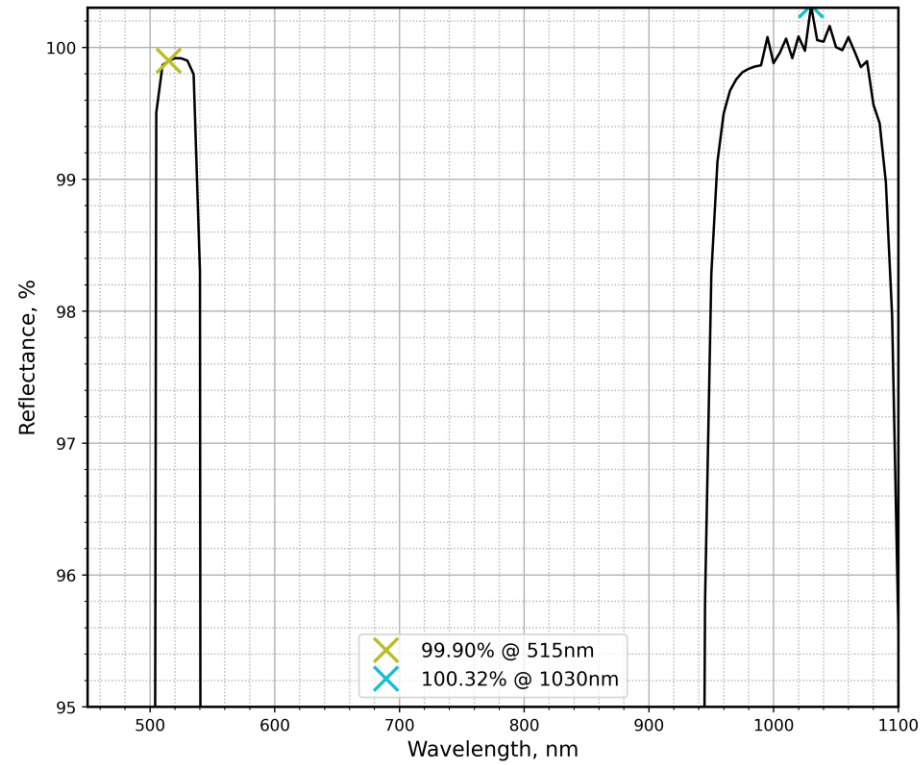
PO3750 i45 Rs

Fig. 1.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%

S1: (arrow marks) HRsp>99.9% @ 1030 nm & HRsp>99.9% @ 515 nm, AOI=45° |GDD Rs|<10 fs², |GDD Rp|<20 fs² @ 1030 nm & 515 nm, AOI=45°
 S2: SCC



PO3750 i45 Rp

Fig. 2.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%